

CE&UKCA EMC Test Report

Project No. : 2012C231B Equipment : LCD Monitor

Brand Name : N/A

Test Model : **34G3******(*=0-9,A-Z,a-z,+,-,/,\ or blank)
Series Model : **34E2*******(*=0-9,A-Z,a-z,+,-,/,\ or blank)

Applicant : TPV Electronics (Fujian) Co., Ltd.

Address : Rongqiao Economic and Technological Development Zone, Fuqing

City, Fujian Province, P.R. China

Date of Receipt : Jul. 11, 2022

Date of Test : Jul. 14, 2022 ~ Aug. 03, 2022

Issued Date : Aug. 23, 2022

Report Version : R00

Test Sample : Engineering Sample No.: DG2022071233

Standard(s) : Please refer to Page 2.

The above equipment has been tested and found compliance with the requirement of the relative standards by BTL Inc.

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lac-MRA AC

TESTING CERT #5123.02

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Standard(s) : EN 55032:2015, Class B

EN 55032:2015+A11:2020, Class B EN 55032:2015+A1:2020, Class B

CISPR 32:2015 / CISPR 32:2015+AMD1:2019

AS/NZS CISPR 32:2015 / AS/NZS CISPR 32:2015+AMD1:2020

EN 61000-3-2:2014 / IEC 61000-3-2:2013, Class D EN IEC 61000-3-2:2019 / IEC 61000-3-2:2018, Class D

EN IEC 61000-3-2:2019+A1:2021, Class D EN 61000-3-3:2013/IEC 61000-3-3:2013

EN 61000-3-3:2013+A1:2019/IEC 61000-3-3:2013+AMD1:2017

EN 55035:2017/CISPR 35:2016 EN 55035:2017+A11:2020

BS EN 55032:2015, Class B

BS EN 55032:2015+A1:2020, Class B

BS EN IEC 61000-3-2:2019+A1:2021, Class D

BS EN 61000-3-3:2013+A1:2019 BS EN 55035:2017+A11:2020



Declaration

BTL represents to the client that testing is done in accordance with standard procedures as applicable and that test instruments used has been calibrated with standards traceable to international standard(s) and/or national standard(s).

BTL's reports apply only to the specific samples tested under conditions. It is manufacture's responsibility to ensure that additional production units of this model are manufactured with the identical electrical and mechanical components. **BTL** shall have no liability for any declarations, inferences or generalizations drawn by the client or others from **BTL** issued reports.

The report must not be used by the client to claim product certification, approval, or endorsement by NVLAP, NIST, A2LA, or any agency of the U.S. Government.

This report is the confidential property of the client. As a mutual protection to the clients, the public and ourselves, the test report shall not be reproduced, except in full, without our written approval.

BTL's laboratory quality assurance procedures are in compliance with the **ISO/IEC 17025** requirements, and accredited by the conformity assessment authorities listed in this test report.

BTL is not responsible for the sampling stage, so the results only apply to the sample as received.

The information, data and test plan are provided by manufacturer which may affect the validity of results, so it is manufacturer's responsibility to ensure that the apparatus meets the essential requirements of applied standards and in all the possible configurations as representative of its intended use.

Limitation

For the use of the authority's logo is limited unless the Test Standard(s)/Scope(s)/Item(s) mentioned in this test report is (are) included in the conformity assessment authorities acceptance respective. Please note that the measurement uncertainty is provided for informational purpose only and are not use in determining the Pass/Fail results.



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REPORT ISSUED HISTORY

Report No.	Version	Description	Issued Date	Note
BTL-EMC-1-2012C231B	R00	Compared with original report (BTL-EMC-1-2012C231A), 1. Added the series model. 2. Added the new base(Type B) for the new model, with the same height and material as the original base. 3. Added a mainboard (model: 715GD177) and powerboard (model:715GA864), so the EMI& Harmonic current&Flicker used the original worst case to tested, the EMS have been re-evaluated and recorded in the test report. In this report only recorded the test results of the new test results. The original test results please refer to original report.	Aug. 23, 2022	Valid